

Form PTO-1449 (Rev. 8-83)		U.S. Department of Commerce Patent and Trademark Office		Atty. Docket No. <b>DRC 099-037</b>		Serial No. <b>Filed herewith</b>	
<b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)				Applicant <b>NASA</b>		Filing Date <b>Filed herewith</b>	
				Inventor <b>NUNNELEE, Mark</b>		Group <b>Not yet assigned</b>	
<b>U.S. PATENT DOCUMENTS</b>							
XMR INIT*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
AA	6,045,517	4Apr00	Williams	600	587	7Apr98	
AB	6,029,528	29Feb00	Headley et al.	73	862.541	17Aug98	
AC	5,938,182	17Aug99	Goodrich et al.	254	209	23Jun97	
AD	5,904,639	18May99	Smyser et al.	482	91	6Mar98	
AE	5,895,084	20Apr99	Mauro	294	100	19Feb97	
AF	5,666,964	16Sep97	Meilus	128	744	6Jun95	
AG	5,649,934	22Jul97	Smeltzer, III et al.	606	122	6Dec94	
AH	5,501,107	26Mar96	Snyder et al.	73	862.23	23Feb93	
AI	5,471,885	5Dec95	Wagner	73	862.041	11Aug93	
AJ	5,471,405	28Nov95	Marsh	364	556	11Jul94	
AK	5,467,656	21Nov95	Teare et al.	73	862.541	20Oct93	
AL	5,435,477	25Jul95	Torihata et al.	228	4.5	2Feb94	
AM	5,337,488	16Aug94	Lemelson	33	784	17Dec92	
AN	5,174,154	29Dec92	Edwards	73	379	12Sep90	
AO	4,911,004	27Mar90	Leon	73	168	15Aug88	
AP	4,738,438	19Apr88	Horie et al.	269	136	22Dec86	
AQ	4,660,481	28Apr87	Spickermann	112	235	6May86	
AR	4,646,563	3Mar87	Jones	73	119	6Apr84	
AS	4,549,355	29Oct85	Sauer, deceased et al.	33	148 H	4Jan84	
AT	4,290,311	22Sep81	Brewer	73	730	8Feb80	
AU	4,066,082	3Jan78	Arcan et al.	128	303 R	20Apr76	
AV	3,965,745	29Jun76	Carey	73	398 AR	5Feb75	
AW	3,898,885	12Aug75	Russell	73	398 AR	15Oct73	
Examiner: <i>Amanda Ellington</i>				Date Considered: <i>3/17/04</i>			

\* Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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XMR INIT*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
(P)	AX	3,866,473	18Feb75	Teitelbaum et al.	73	398 AR	4Aug69
↓	AY	3,750,475	7Aug73	Weaver	73	398 AR	3Aug72
↓	AZ	3,603,152	7Sep71	Alibert et al.	73	398 R	5Feb70
(P)	BA	3,535,937	27Oct70	Wiggins et al.	73	398	31Dec68
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
		N/A					
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
(P)	BB	Datasheet for "INA125, Instrumentation Amplifier With Precision Voltage Reference," Texas Instruments, 1 page, from <a href="http://focus.ti.com/docs/prod/productfolder.jhtml?genericPartNumber=INA125">http://focus.ti.com/docs/prod/productfolder.jhtml?genericPartNumber=INA125</a> .					
↓	BC	Product folder for "INA125, Instrumentation Amplifier with Precision Voltage Reference, Texas Instruments, Burr-Brown Products, 17 pps., from <a href="http://focus.ti.com/docs/prod/folders/print/ina125.html">http://focus.ti.com/docs/prod/folders/print/ina125.html</a> .					
↓	BD	"Micro-Measurements Strain Gage Accessories: M-Bond 610 Adhesive," 2 pps., from <a href="http://www.vishay.com/brands/measurements_group/guide/a110/acc/mb610.htm">http://www.vishay.com/brands/measurements_group/guide/a110/acc/mb610.htm</a> .					
↓	BE	"M-Bond AE-10, AE-15 and GA-2 Installations: Mixing Instructions and Adhesive Characteristics," 1 page, from <a href="http://www.vishay.com/brands/measurements_group/guide/ib/b137/137cl.htm">http://www.vishay.com/brands/measurements_group/guide/ib/b137/137cl.htm</a> .					
(P)	BF	"Stress, Strain, and Strain Gages," 9 pps., from <a href="http://www.me.psu.edu/me82/learning/strain/strain.html">http://www.me.psu.edu/me82/learning/strain/strain.html</a> .					
Examiner: <i>Alandra Ellington</i>				Date Considered: <i>9/17/04</i>			

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